

# MOSFET - Power, Single N-Channel, μ8FL 30 V, 2.25 mΩ, 162 A

## **NVTFS4C02N**

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVTFS4C02NWF Wettable Flanks Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- Reverse Battery Protection
- DC-DC Converter Output Driver

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

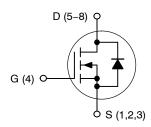
Param	Symbol	Value	Unit		
Drain-to-Source Voltage	$V_{DSS}$	30	V		
Gate-to-Source Voltage	$V_{GS}$	±20	V		
Continuous Drain					Α
Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 100°C		20	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	3.2	W
R <sub>θJA</sub> (Note 2)	Steady	T <sub>A</sub> = 100°C		1.6	W
Continuous Drain	State	T <sub>C</sub> = 25°C	I <sub>D</sub>	162	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		115	
Power Dissipation		T <sub>C</sub> = 25°C	$P_{D}$	107	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		53.5	W
Pulsed Drain Current	T <sub>A</sub> = 25°	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	500	Α
Operating Junction and S Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C		
Source Current (Body Did	Source Current (Body Diode)				
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-So (I <sub>L</sub> = 37 A <sub>pk</sub> ) (Note 3)	E <sub>AS</sub>	162	mJ		
Lead Temperature for So (1/8" from case for 10 s)	TL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum ratings. Parts are 100% tested at  $T_J=25^{\circ}C$ ,  $V_{GS}=10$  V,  $I_L=36$  A,  $E_{AS}=65$  mJ.

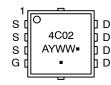
V <sub>(BR)DSS</sub> R <sub>DS(on)</sub> MAX		I <sub>D</sub> MAX
30 V	2.25 mΩ @ 10 V	162 A
	3.1 mΩ @ 4.5 V	1027

#### **N-Channel MOSFET**



# WDFN8 1 CASE 511AB S

WDFNW8 CASE 515AN



4C02 = Specific Device Code 02WF = Specific Device Code of NVTFS4C02NWF

A = Assembly Location
Y = Year
WW = Work Week
Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>	
NVTFS4C02NTAG	WDFN8	1500 / Tape &	
NVTFS4C02NWFTAG	WDFNW8	Reel	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	1.4	°C/W
Junction-to-Ambient - Steady State	$R_{\theta JA}$	46	C/VV

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				13.8		mV/°0
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μА
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 30 V	T <sub>J</sub> = 25°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 250 μΑ	1.3	1.6	2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.0		mV/°
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 20 A		1.9	2.25	<b></b> (
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 20 A		2.7	3.1	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 50 A			140		S
Gate Resistance	$R_{G}$				0.9		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			2980		
Output Capacitance	C <sub>OSS</sub>				1200		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				55		
Output Charge	Q <sub>OSS</sub>	$V_{GS} = 0 \text{ V}, V_{D}$	<sub>D</sub> = 15 V		25		nC
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15	5 V, f = 1 MHz		0.018		
Total Gate Charge	Q <sub>G(TOT)</sub>				20		
Threshold Gate Charge	Q <sub>G(TH)</sub>				4.7		nC
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 50 \text{ A}$			8.5		lic
Gate-to-Drain Charge	$Q_{GD}$				4		
Gate Plateau Voltage	$V_{GP}$				2.8		V
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 50 A			45		nC
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t <sub>d(ON)</sub>				12		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 50 A, $R_{G}$ = 3.0 $\Omega$			116		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				25		ns
Fall Time	t <sub>f</sub>				10		

<sup>4.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 5. Switching characteristics are independent of operating junction temperatures.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

					_		
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	lote 5)						
Turn-On Delay Time	t <sub>d(ON)</sub>				9		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 50 A, $R_{G}$ = 3.0 $\Omega$			102		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				33		
Fall Time	t <sub>f</sub>	1			6		1
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 \text{ V},$ $I_{S} = 20 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$			8.0	1.1	.,,
					0.6		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dI}_{S}/\text{dt} = 100 \text{ A}/\mu\text{s,}$ $I_{S} = 50 \text{ A}$			42		
Charge Time	t <sub>a</sub>				21		ns
Discharge Time	t <sub>b</sub>				21		
Reverse Recovery Charge	Q <sub>RR</sub>				28		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

<sup>4.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

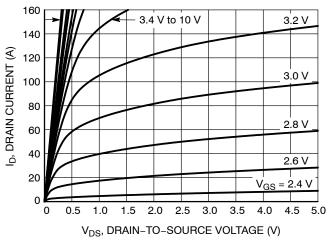


Figure 1. On-Region Characteristics

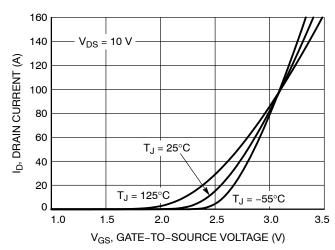


Figure 2. Transfer Characteristics

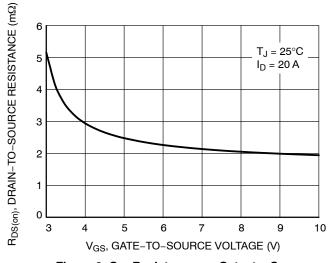


Figure 3. On-Resistance vs. Gate-to-Source Voltage

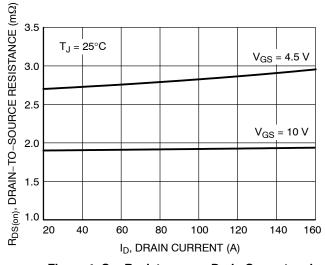


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

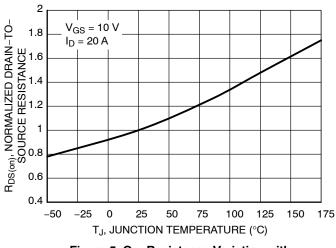


Figure 5. On–Resistance Variation with Temperature

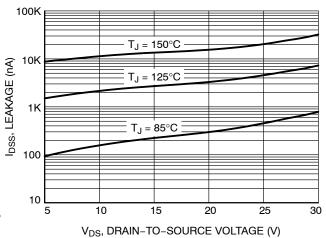
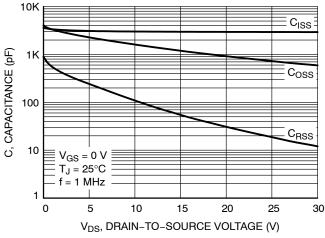


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**



<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE ( Figure 7. Capacitance Variation

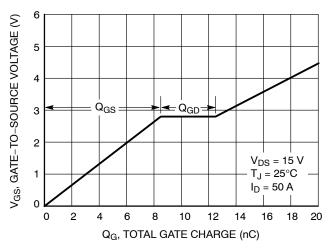


Figure 8. Gate-to-Source vs. Total Charge

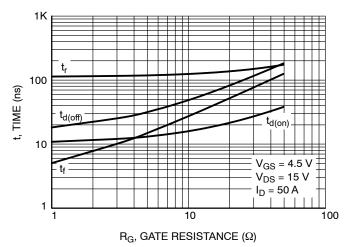


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

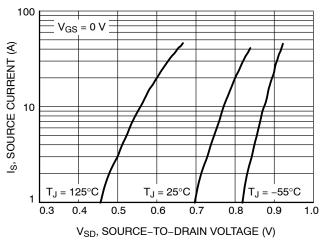


Figure 10. Diode Forward Voltage vs. Current

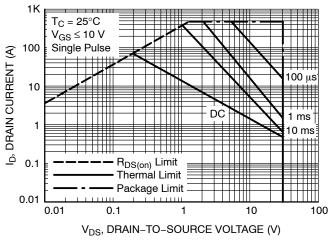


Figure 11. Maximum Rated Forward Biased Safe Operating Area

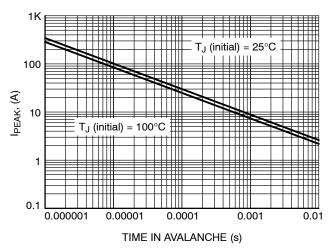


Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

### **TYPICAL CHARACTERISTICS**

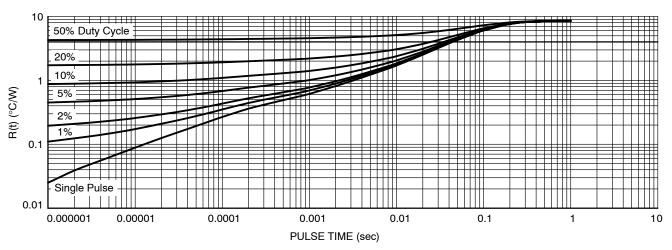
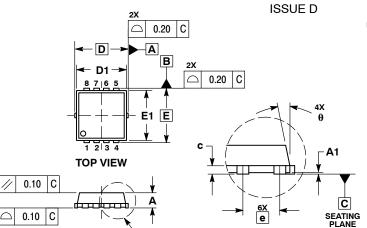


Figure 13. Thermal Characteristics

#### **PACKAGE DIMENSIONS**

#### WDFN8 3.3x3.3, 0.65P CASE 511AB

**DETAIL A** 



DETAIL A

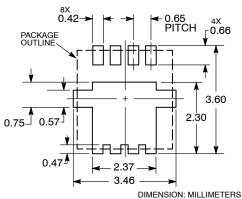
- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		O	.130 BSC	)
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC	;	0	.130 BSC	
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC		(	0.026 BS0	0
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

#### С АВ 0.10 Ф 0.05 С 4X L **Å** E2 ▼ E3\_ D2 **BOTTOM VIEW**

SIDE VIEW

#### **SOLDERING FOOTPRINT\***

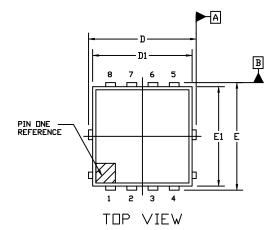


\*For additional information on our Pb-Free strategy and soldering details, please download the **onsemi** Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

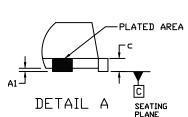
#### WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF)

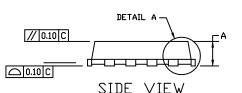
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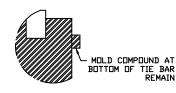


#### NOTES:

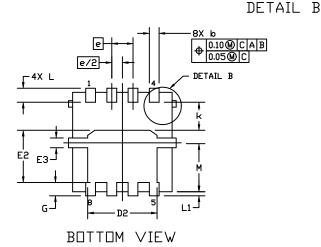
- 1. DIMENSIONING AND TOLERANCING PER.ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

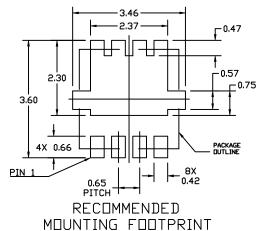






	MILLIMETERS			
DIM	MIN.	NDM.	MAX.	
A	0.70	0.75	0.80	
A1	0.00		0.05	
b	0.23	0.30	0.40	
n	0.15	0.20	0.25	
D	3.05	3.30	3.55	
D1	2.95	3.05	3.15	
DS	1.98	2.11	2.24	
Ε	3.05	3.30	3.55	
E1	2.95	3.05	3.15	
E2	1.47	1.60	1.73	
E3	0.23	0.30	0.40	
a		0.65 BSC		
G	0.30	0.41	0.51	
K	0.65	0.80	0.95	
L	0.30	0.43	0.59	
L1	0.06	0.13	0.20	
М	1.40	1.50	1.60	





For additional information on our Pb-Free strategy and soldering details, please download the IN Semiconductor Soldering and Mounting Techniques Reference Manual, SILDERRM/D.

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